

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VCX574FT, TC74VCX574FK

Low-Voltage Octal D-Type Flip-Flop with 3.6 V Tolerant Inputs and Outputs

The TC74VCX574 is a high performance CMOS octal D-type flip-flop which is guaranteed to operate from 1.2-V to 3.6-V. Designed for use in 1.5 V, 1.8 V, 2.5 V or 3.3 V systems, it achieves high speed operation while maintaining the CMOS low power dissipation.

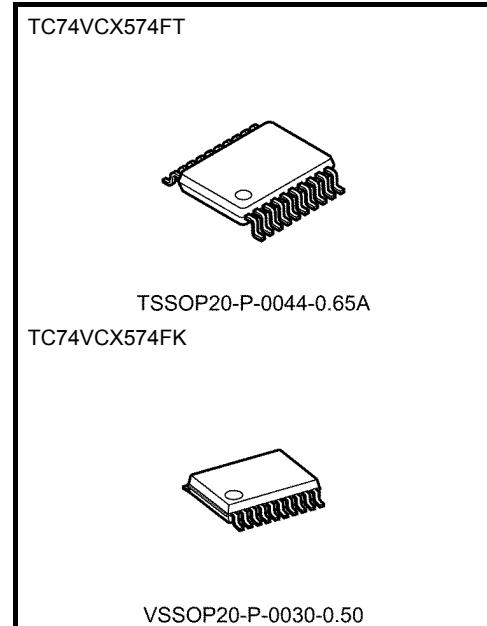
It is also designed with over voltage tolerant inputs and outputs up to 3.6 V.

This 8 bit D-type flip-flop is controlled by a clock input (CK) and an output enable input (\overline{OE}). When \overline{OE} input is high, the eight outputs are in a high impedance state.

All inputs are equipped with protection circuits against static discharge.

Features

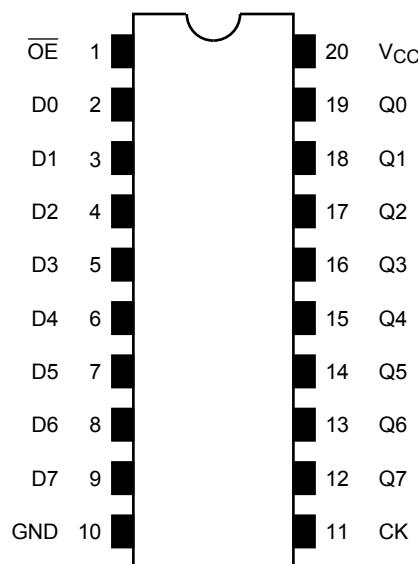
- Low voltage operation: $V_{CC} = 1.2$ to 3.6 V
- High speed operation: $t_{pd} = 4.2$ ns (max) ($V_{CC} = 3.0$ to 3.6 V)
 $t_{pd} = 4.8$ ns (max) ($V_{CC} = 2.3$ to 2.7 V)
 $t_{pd} = 9.6$ ns (max) ($V_{CC} = 1.65$ to 1.95 V)
 $t_{pd} = 19.2$ ns (max) ($V_{CC} = 1.4$ to 1.6 V)
 $t_{pd} = 48.0$ ns (max) ($V_{CC} = 1.2$ V)
- 3.6 V tolerant inputs and outputs.
- Output current: $I_{OH}/I_{OL} = \pm 24$ mA (min) ($V_{CC} = 3.0$ V)
 $I_{OH}/I_{OL} = \pm 18$ mA (min) ($V_{CC} = 2.3$ V)
 $I_{OH}/I_{OL} = \pm 6$ mA (min) ($V_{CC} = 1.65$ V)
 $I_{OH}/I_{OL} = \pm 2$ mA (min) ($V_{CC} = 1.4$ V)
- Latch-up performance: -300 mA
- ESD performance: Machine model $\geq \pm 200$ V
Human body model $\geq \pm 2000$ V
- Package: TSSOP and VSSOP (US)
- Power down protection is provided on all inputs and outputs.



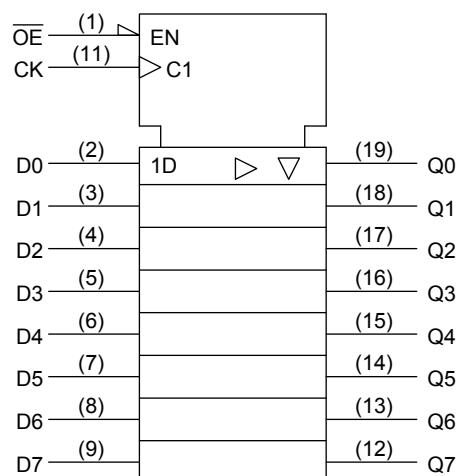
Weight	
TSSOP20-P-0044-0.65A	: 0.08 g (typ.)
VSSOP20-P-0030-0.50	: 0.03 g (typ.)

Start of commercial production
1998-06

Pin Assignment (top view)



IEC Logic Level



Truth Table

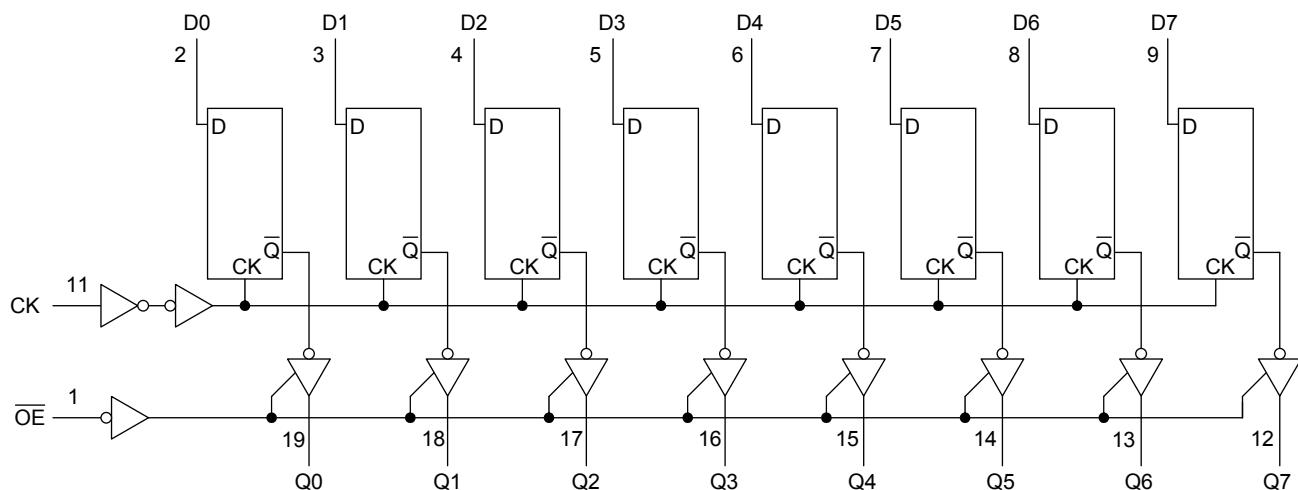
Inputs			Outputs
OE	CK	D	
H	X	X	Z
L	↓	X	Q _n
L	↑	L	L
L	↑	H	H

X: Don't care

Z: High impedance

Q_n: No change

System Diagram



Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V _{CC}	-0.5 to 4.6	V
DC input voltage	V _{IN}	-0.5 to 4.6	V
DC output voltage	V _{OUT}	-0.5 to 4.6 (Note 2)	V
		-0.5 to V _{CC} + 0.5 (Note 3)	
Input diode current	I _{IK}	-50	mA
Output diode current	I _{OK}	±50 (Note 4)	mA
DC output current	I _{OUT}	±50	mA
Power dissipation	P _D	180	mW
DC V _{CC} /ground current	I _{CC/GND}	±100	mA
Storage temperature	T _{stg}	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Note 2: Off-state

Note 3: High or low state. I_{OUT} absolute maximum rating must be observed.

Note 4: V_{OUT} < GND, V_{OUT} > V_{CC}

Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage	V _{CC}	1.2 to 3.6	V
Input voltage	V _{IN}	-0.3 to 3.6	V
Output voltage	V _{OUT}	0 to 3.6 (Note 2)	V
		0 to V _{CC} (Note 3)	
Output current	I _{OH/I_{OL}}	±24 (Note 4)	mA
		±18 (Note 5)	
		±6 (Note 6)	
		±2 (Note 7)	
Operating temperature	T _{opr}	-40 to 85	°C
Input rise and fall time	d _{t/dv}	0 to 10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either V_{CC} or GND.

Note 2: Off-state

Note 3: High or low state

Note 4: V_{CC} = 3.0 to 3.6 V

Note 5: V_{CC} = 2.3 to 2.7 V

Note 6: V_{CC} = 1.65 to 1.95 V

Note 7: V_{CC} = 1.4 to 1.6 V

Note 8: V_{IN} = 0.8 to 2.0 V, V_{CC} = 3.0 V

Electrical Characteristics**DC Characteristics (Ta = -40 to 85°C, 2.7 V < V_{CC} ≤ 3.6 V)**

Characteristics		Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit	
Input voltage	High level							
	Low level	V _{IIL}	—	2.7 to 3.6	—	0.8	V	
Output voltage	High level	V _{OH}	V _{IN} = V _{IH} or V _{IIL}	I _{OH} = -100 μA	2.7 to 3.6	V _{CC} - 0.2	—	
				I _{OH} = -12 mA	2.7	2.2	—	
				I _{OH} = -18 mA	3.0	2.4	—	
				I _{OH} = -24 mA	3.0	2.2	—	
	Low level	V _{OL}	V _{IN} = V _{IH} or V _{IIL}	I _{OL} = 100 μA	2.7 to 3.6	—	0.2	
				I _{OL} = 12 mA	2.7	—	0.4	
				I _{OL} = 18 mA	3.0	—	0.4	
				I _{OL} = 24 mA	3.0	—	0.55	
Input leakage current		I _{IN}	V _{IN} = 0 to 3.6 V	2.7 to 3.6	—	±5.0	μA	
3-state output off-state current		I _{OZ}	V _{IN} = V _{IH} or V _{IIL} V _{OUT} = 0 to 3.6 V	2.7 to 3.6	—	±10.0	μA	
Power off leakage current		I _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V	0	—	10.0	μA	
Quiescent supply current	I _{QC}	V _{IN} = V _{CC} or GND		2.7 to 3.6	—	20.0	μA	
		V _{CC} ≤ (V _{IN} , V _{OUT}) ≤ 3.6 V		2.7 to 3.6	—	±20.0		
	ΔI _{QC}	V _{IH} = V _{CC} - 0.6 V (per input)		2.7 to 3.6	—	750		

DC Characteristics (Ta = -40 to 85°C, 2.3 V ≤ V_{CC} ≤ 2.7 V)

Characteristics		Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit	
Input voltage	High level							
	Low level	V _{IIL}	—	2.3 to 2.7	—	0.7	V	
Output voltage	High level	V _{OH}	V _{IN} = V _{IH} or V _{IIL}	I _{OH} = -100 μA	2.3 to 2.7	V _{CC} - 0.2	—	
				I _{OH} = -6 mA	2.3	2.0	—	
				I _{OH} = -12 mA	2.3	1.8	—	
				I _{OH} = -18 mA	2.3	1.7	—	
	Low level	V _{OL}	V _{IN} = V _{IH} or V _{IIL}	I _{OL} = 100 μA	2.3 to 2.7	—	0.2	
				I _{OL} = 12 mA	2.3	—	0.4	
				I _{OL} = 18 mA	2.3	—	0.6	
				—	—	—	—	
Input leakage current		I _{IN}	V _{IN} = 0 to 3.6 V	2.3 to 2.7	—	±5.0	μA	
3-state output off-state current		I _{OZ}	V _{IN} = V _{IH} or V _{IIL} V _{OUT} = 0 to 3.6 V	2.3 to 2.7	—	±10.0	μA	
Power off leakage current		I _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V	0	—	10.0	μA	
Quiescent supply current	I _{QC}	V _{IN} = V _{CC} or GND		2.3 to 2.7	—	20.0	μA	
		V _{CC} ≤ (V _{IN} , V _{OUT}) ≤ 3.6 V		2.3 to 2.7	—	±20.0		

DC Characteristics ($T_a = -40$ to 85°C , $1.65 \text{ V} \leq V_{CC} < 2.3 \text{ V}$)

Characteristics		Symbol	Test Condition		$V_{CC} (\text{V})$	Min	Max	Unit
Input voltage	High level		—	1.65 to 2.3	$0.65 \times V_{CC}$	—		V
	Low level	V_{IL}	—	1.65 to 2.3	—	—	$0.2 \times V_{CC}$	
Output voltage	High level	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -100 \mu\text{A}$	1.65 to 2.3	$V_{CC} - 0.2$	—	V
	Low level	V_{OL}		$I_{OH} = -6 \text{ mA}$	1.65	1.25	—	
	High level	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 100 \mu\text{A}$	1.65 to 2.3	—	0.2	
	Low level	V_{OL}		$I_{OL} = 6 \text{ mA}$	1.65	—	0.3	
Input leakage current		I_{IN}	$V_{IN} = 0$ to 3.6 V		1.65 to 2.3	—	± 5.0	μA
3-state output off-state current		I_{OZ}	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = 0$ to 3.6 V		1.65	—	± 10.0	μA
Power off leakage current		I_{OFF}	$V_{IN}, V_{OUT} = 0$ to 3.6 V		0	—	10.0	μA
Quiescent supply current		I_{CC}	$V_{IN} = V_{CC}$ or GND		1.65 to 2.3	—	20.0	μA
			$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6 \text{ V}$		1.65 to 2.3	—	± 20.0	

DC Characteristics ($T_a = -40$ to 85°C , $1.4 \text{ V} \leq V_{CC} < 1.65 \text{ V}$)

Characteristics		Symbol	Test Condition		$V_{CC} (\text{V})$	Min	Max	Unit
Input voltage	High level		—	1.4 to 1.65	$0.65 \times V_{CC}$	—		V
	Low level	V_{IL}	—	1.4 to 1.65	—	—	$0.05 \times V_{CC}$	
Output voltage	High level	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -100 \mu\text{A}$	1.4 to 1.65	$V_{CC} - 0.2$	—	V
	Low level	V_{OL}		$I_{OH} = -2 \text{ mA}$	1.4	1.05	—	
	High level	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 100 \mu\text{A}$	1.4 to 1.65	—	0.05	
	Low level	V_{OL}		$I_{OL} = 2 \text{ mA}$	1.4	—	0.35	
Input leakage current		I_{IN}	$V_{IN} = 0$ to 3.6 V		1.4 to 1.65	—	± 5.0	μA
3-state output off-state current		I_{OZ}	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = 0$ to 3.6 V		1.4 to 1.65	—	± 10.0	μA
Power off leakage current		I_{OFF}	$V_{IN}, V_{OUT} = 0$ to 3.6 V		0	—	10.0	μA
Quiescent supply current		I_{CC}	$V_{IN} = V_{CC}$ or GND		1.4 to 1.65	—	20.0	μA
			$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6 \text{ V}$		1.4 to 1.65	—	± 20.0	

DC Characteristics ($T_a = -40$ to 85°C , $1.2 \text{ V} \leq V_{CC} < 1.4 \text{ V}$)

Characteristics		Symbol	Test Condition		$V_{CC} (\text{V})$	Min	Max	Unit
Input voltage	High level		—	1.2 to 1.4				
	Low level	V_{IL}	—	1.2 to 1.4	—	—	$0.05 \times V_{CC}$	V
Output voltage	High level	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -100 \mu\text{A}$	1.2	$V_{CC} - 0.1$	—	V
	Low level	V_{OL}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 100 \mu\text{A}$	1.2	—	0.05	
Input leakage current	I_{IN}	$V_{IN} = 0$ to 3.6 V		1.2	—	± 5.0	μA	
3-state output off-state current	I_{OZ}	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = 0$ to 3.6 V		1.2	—	± 10.0	μA	
Power off leakage current	I_{OFF}	$V_{IN}, V_{OUT} = 0$ to 3.6 V		0	—	10.0	μA	
Quiescent supply current	I_{CC}	$V_{IN} = V_{CC}$ or GND		1.2	—	20.0	μA	
		$V_{CC} \leq (V_{IN}, V_{OUT}) \leq 3.6 \text{ V}$		1.2	—	± 20.0		

AC Characteristics ($T_a = -40$ to 85°C , Input: $t_r = t_f = 2.0$ ns) (Note 1)

Characteristics	Symbol	Test Condition	V_{CC} (V)	Min	Max	Unit
Maximum clock frequency	f_{max}	Figure 1, Figure 2	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	40	—
				1.5 ± 0.1	80	—
			$C_L = 30 \text{ pF}, R_L = 500 \Omega$	1.8 ± 0.15	100	—
				2.5 ± 0.2	200	—
				3.3 ± 0.3	250	—
						MHz
Propagation delay time (CK-Q)	t_{pLH} t_{pHL}	Figure 1, Figure 2	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	1.5	48
				1.5 ± 0.1	1.0	19.2
			$C_L = 30 \text{ pF}, R_L = 500 \Omega$	1.8 ± 0.15	1.5	9.6
				2.5 ± 0.2	0.8	4.8
				3.3 ± 0.3	0.6	4.2
						ns
3-state output enable time	t_{pZL} t_{pZH}	Figure 1, Figure 3	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	1.5	49.0
				1.5 ± 0.1	1.0	19.6
			$C_L = 30 \text{ pF}, R_L = 500 \Omega$	1.8 ± 0.15	1.5	9.8
				2.5 ± 0.2	0.8	5.5
				3.3 ± 0.3	0.6	4.5
						ns
3-state output disable time	t_{pLZ} t_{pHZ}	Figure 1, Figure 3	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	1.5	32.5
				1.5 ± 0.1	1.0	13.0
			$C_L = 30 \text{ pF}, R_L = 500 \Omega$	1.8 ± 0.15	1.5	6.5
				2.5 ± 0.2	0.8	3.6
				3.3 ± 0.3	0.6	3.3
						ns
Minimum pulse width (CK)	$t_w(H)$ $t_w(L)$	Figure 1, Figure 2	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	24	—
				1.5 ± 0.1	8.0	—
			$C_L = 30 \text{ pF}, R_L = 500 \Omega$	1.8 ± 0.15	4.0	—
				2.5 ± 0.2	1.5	—
				3.3 ± 0.3	1.5	—
						ns
Minimum set-up time	t_s	Figure 1, Figure 2	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	20	—
				1.5 ± 0.1	7.5	—
			$C_L = 30 \text{ pF}, R_L = 500 \Omega$	1.8 ± 0.15	2.5	—
				2.5 ± 0.2	1.5	—
				3.3 ± 0.3	1.5	—
						ns
Minimum hold time	t_h	Figure 1, Figure 2	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	0.8	—
				1.5 ± 0.1	3.0	—
			$C_L = 30 \text{ pF}, R_L = 500 \Omega$	1.8 ± 0.15	1.0	—
				2.5 ± 0.2	1.0	—
				3.3 ± 0.3	1.0	—
						ns
Output to output skew	t_{osLH} t_{osHL}	(Note 2)	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	1.2	—	1.5
				1.5 ± 0.1	—	1.5
			$C_L = 30 \text{ pF}, R_L = 500 \Omega$	1.8 ± 0.15	—	0.5
				2.5 ± 0.2	—	0.5
				3.3 ± 0.3	—	0.5
						ns

Note 1: For $C_L = 50 \text{ pF}$, add approximately 300 ps to the AC maximum specification.

Note 2: This parameter is guaranteed by design. ($t_{osLH} = |t_{pLHm} - t_{pLHn}|$, $t_{osHL} = |t_{pHLm} - t_{pHLn}|$)

Dynamic Switching Characteristics (Ta = 25°C, Input: t_r = t_f = 2.0 ns, C_L = 30 pF)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Typ.	Unit
Quiet output maximum dynamic V _{OL}	V _{O LP}	V _{IH} = 1.8 V, V _{IL} = 0 V (Note)	1.8	0.25	V
		V _{IH} = 2.5 V, V _{IL} = 0 V (Note)	2.5	0.6	
		V _{IH} = 3.3 V, V _{IL} = 0 V (Note)	3.3	0.8	
Quiet output minimum dynamic V _{OL}	V _{O LV}	V _{IH} = 1.8 V, V _{IL} = 0 V (Note)	1.8	-0.25	V
		V _{IH} = 2.5 V, V _{IL} = 0 V (Note)	2.5	-0.6	
		V _{IH} = 3.3 V, V _{IL} = 0 V (Note)	3.3	-0.8	
Quiet output minimum dynamic V _{OH}	V _{O HV}	V _{IH} = 1.8 V, V _{IL} = 0 V (Note)	1.8	1.5	V
		V _{IH} = 2.5 V, V _{IL} = 0 V (Note)	2.5	1.9	
		V _{IH} = 3.3 V, V _{IL} = 0 V (Note)	3.3	2.2	

Note: This parameter is guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

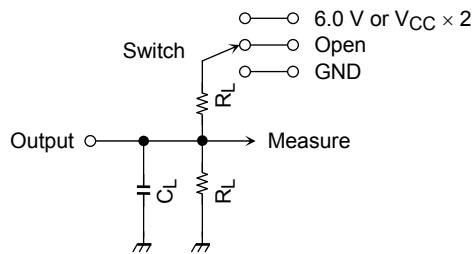
Characteristics	Symbol	Test Condition	V _{CC} (V)	Typ.	Unit
Input capacitance	C _{IN}	—	1.8, 2.5, 3.3	6	pF
Output capacitance	C _O	—	1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz (Note)	1.8, 2.5, 3.3	20	pF

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC}(\text{opr}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per bit)}$$

AC Test Circuit

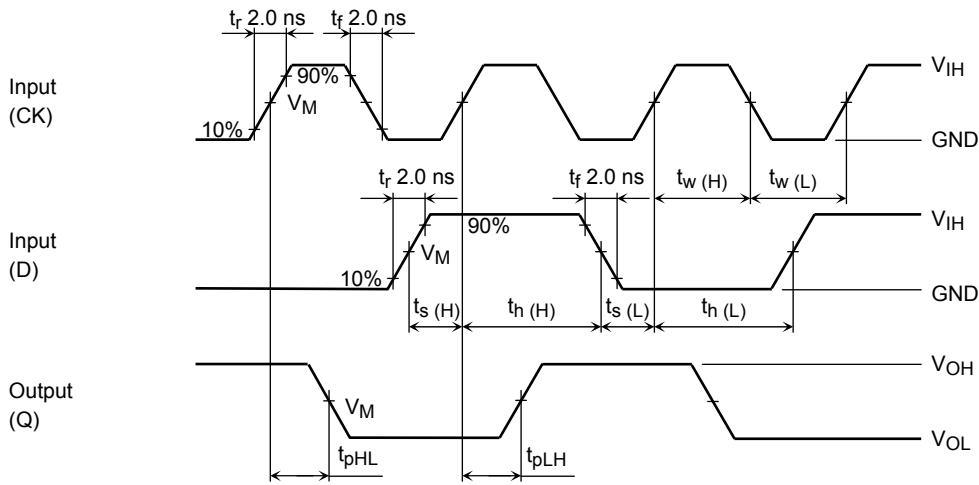


Parameter	Switch	
t_{PLH}, t_{PHL}	Open	
t_{PLZ}, t_{PZL}	6.0 V $V_{CC} \times 2$	@ $V_{CC} = 3.3 \pm 0.3$ V @ $V_{CC} = 2.5 \pm 0.2$ V @ $V_{CC} = 1.8 \pm 0.15$ V @ $V_{CC} = 1.5 \pm 0.1$ V @ $V_{CC} = 1.2$ V
t_{PHZ}, t_{PZH}	GND	

Symbol	V_{CC}	
	3.3 ± 0.3 V 2.5 ± 0.2 V 1.8 ± 0.15 V	1.5 ± 0.1 V 1.2 V
R_L	500Ω	2kΩ
C_L	30pF	15pF

Figure 1

AC Waveform

Figure 2 $t_{PLH}, t_{PHL}, t_w, t_s, t_h$

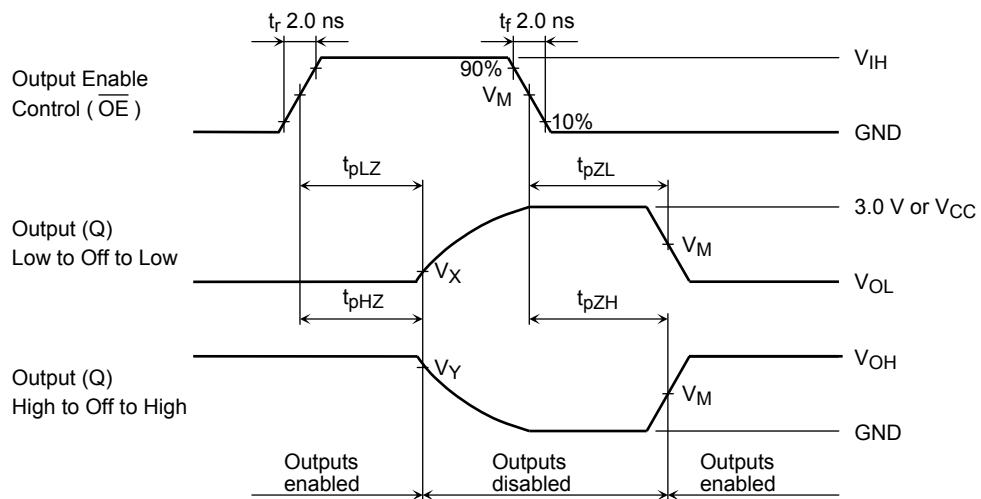


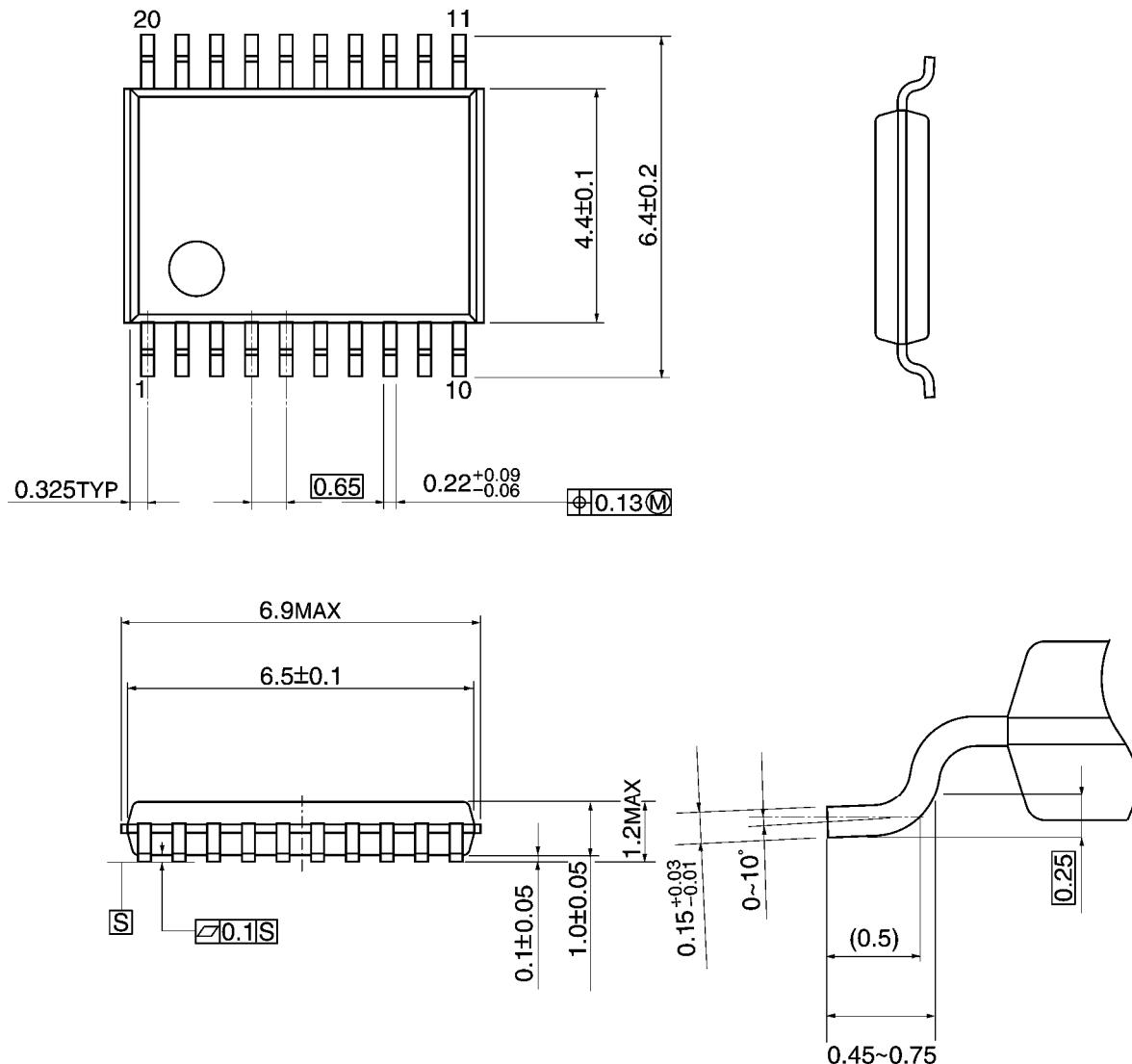
Figure 3 t_{PLZ} , t_{PHZ} , t_{PZL} , t_{PZH}

Symbol	V_{CC}				
	$3.3 \pm 0.3 \text{ V}$	$2.5 \pm 0.2 \text{ V}$	$1.8 \pm 0.15 \text{ V}$	$1.5 \pm 0.1 \text{ V}$	1.2 V
V_{IH}	2.7 V	V_{CC}	V_{CC}	V_{CC}	V_{CC}
V_M	1.5 V	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$
V_X	$V_{OL} + 0.3 \text{ V}$	$V_{OL} + 0.15 \text{ V}$	$V_{OL} + 0.15 \text{ V}$	$V_{OL} + 0.1 \text{ V}$	$V_{OL} + 0.1 \text{ V}$
V_Y	$V_{OH} - 0.3 \text{ V}$	$V_{OH} - 0.15 \text{ V}$	$V_{OH} - 0.15 \text{ V}$	$V_{OH} - 0.1 \text{ V}$	$V_{OH} - 0.1 \text{ V}$

Package Dimensions

TSSOP20-P-0044-0.65A

Unit: mm

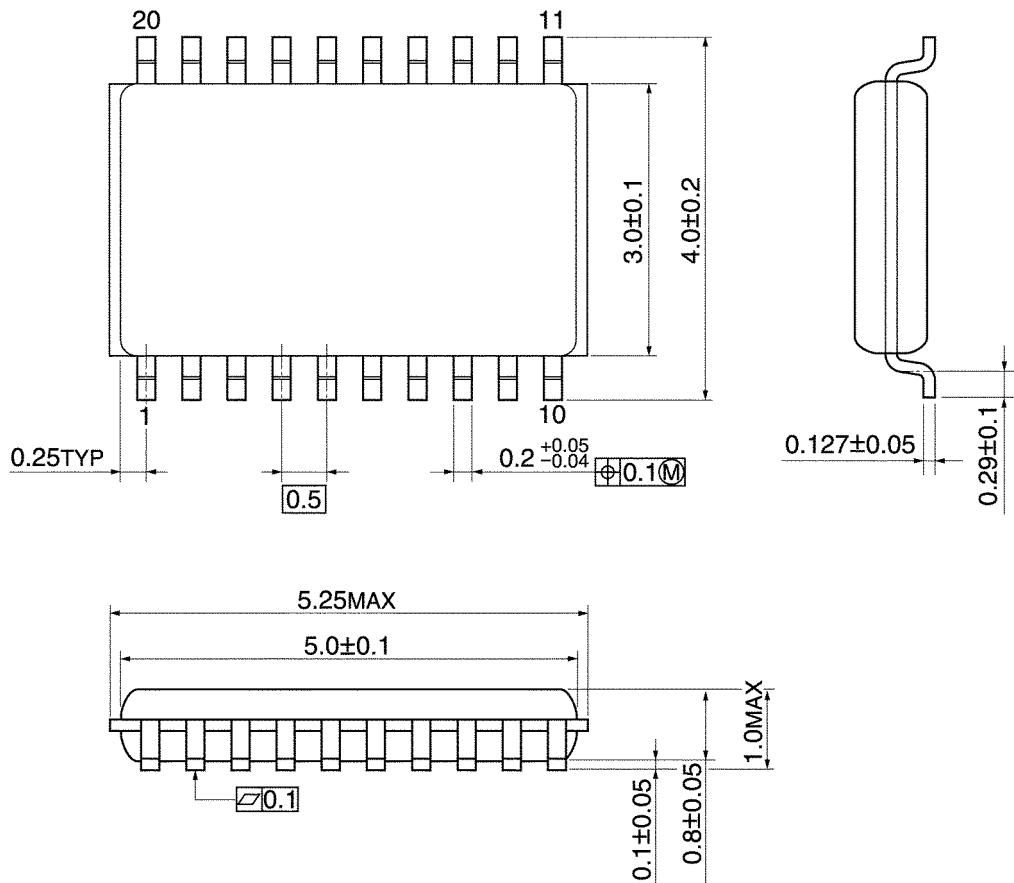


Weight: 0.08 g (typ.)

Package Dimensions

VSSOP20-P-0030-0.50

Unit: mm



Weight: 0.03 g (typ.)

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